Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | CHENG ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
*	Α	US-6,524,938 B1	02-2003	Tao et al.	438/585
*	В	US-20040195646	10-2004	Yeo et al.	257/527
*	С	US-6,774,409 B2	08-2004	Baba et al.	257/189
*	D	US-6,187,641 B1	02-2001	Rodder et al.	438/299
*	E	US-6,348,390 B1	02-2002	Wu, Shye-Lin	438/305
*	F	US-2004/0173815	09-2004	Yeo et al.	257/192
	G	US-2004/0175872	09-2004	Yeo et al.	438/154
	H	US-			
	ı	US-			
	J	US-			,
	К	US-			
	L	US-			
	М	US-	·		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	0				-	·
	Р					
	ď					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Shimizu et al. Local mechanical stress control, IEDM 2001, pp 433-436
	٧	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.